TOSHIBA Field Effect Transistor Silicon P Channel MOS Type ($L^2-\pi$ -MOSV)

2SJ512

Chopper Regulator, DC-DC Converter and Motor Drive Applications

• Low drain-source ON resistance $RDS(ON) = 1.0 \Omega \text{ (typ.)}$

• High forward transfer admittance : $|Y_{fs}| = 3.7 \text{ S (typ.)}$

• Low leakage current : $IDSS = -100 \mu A (max) (VDS = -250 V)$

• Enhancement-mode : $V_{th} = -1.5 \sim -3.5 \text{ V (V}_{DS} = -10 \text{ V, I}_{D} = -1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	-250	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	-250	V	
Gate-source voltage		V_{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	-5	Α	
	Pulse (Note 1)	I _{DP}	-20	Α	
Drain power dissipation	n (Tc = 25°C)	P _D	30	W	
Single pulse avalanche energy (Note 2)		E _{AS}	155	mJ	
Avalanche current		I _{AR}	-5	Α	
Repetitive avalenche energy (Note 3)		E _{AR}	3.0	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Weight: 1.9 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	4.16	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	62.5	°C/W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

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Note 2: V_{DD} = -50 V, T_{ch} = 25°C (initial), L = 10.5 mH, R_G = 25 Ω , I_{AR} = -5 A

Note 3: Repetitive rating; Pulse width limited by maximum channel temperature.

This transistor is an electrostatic sensitive device.

Please handle with caution.

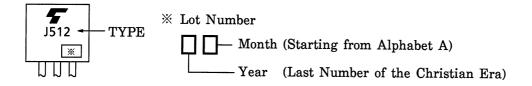
Electrical Characteristics (Ta = 25°C)

Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off cur	rent	I _{DSS}	V _{DS} = -250 V, V _{GS} = 0 V	_	_	-100	μΑ
Drain-source brovoltage	eakdown	V _{(BR) DSS}	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-250	_	_	V
Gate threshold v	roltage	V_{th}	$V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA}$	-1.5	_	-3.5	V
Drain-source Ol	N resistance	R _{DS} (ON)	$V_{GS} = -10 \text{ V}, I_D = -2.5 \text{ A}$	_	1.0	1.25	Ω
Forward transfer	admittance	Y _{fS}	V _{DS} = -10 V, I _D = -2.5 A	1.8	3.7	_	S
Input capacitanc	е	C _{iss}		_	800	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	80	_	pF
Output capacitance		C _{oss}	1		250	_	
Switching time	Rise time	t _r	V_{GS}^{OV} $I_{D} = -2.5A$ V_{OUT} $R_{L} = 40\Omega$ $V_{DD} = -100V$	_	16	_	
	Turn-on time	t _{on}		_	35	_	
	Fall time	t _f		_	9	_	ns
	Turn-off time	t _{off}	Duty $\leq 1\%$, $t_{\mathbf{W}} = 10 \mu \text{s}$	_	70	_	
Total gate charge (Gate-source plus gate-drain)		Q_{g}	V _{DD} ≈ -200 V, V _{GS} = -10 V,	_	22		nC
Gate-source charge		Q_{gs}	I _D = -5 A	_	14	_	
Gate-drain ("miller") charge		Q_{gd}			8	_	

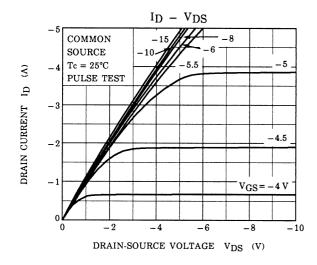
Source-Drain Ratings and Characteristics (Ta = 25°C)

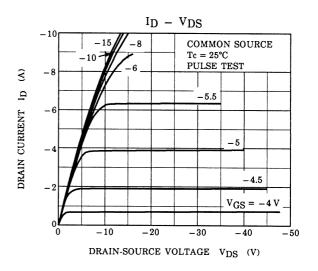
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	1	_	-5	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	-20	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = -5 A, V _{GS} = 0 V	_	_	2.0	V
Reverse recovery time	t _{rr}	I _{DR} = -5 A, V _{GS} = 0 V		205	_	ns
Reverse recovery charge	Q _{rr}	dl _{DR} / dt = 100 A / μs		2.1	_	μC

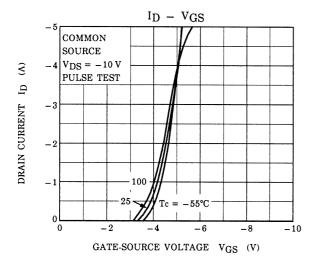
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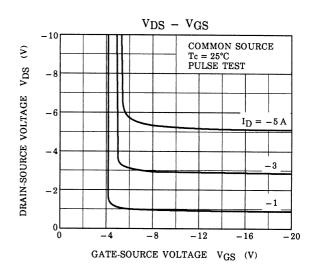


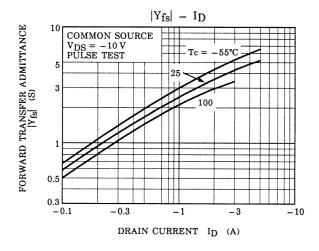
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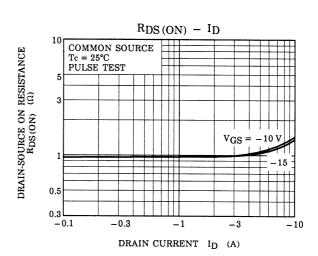




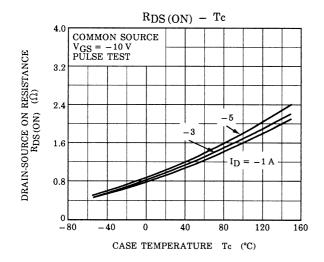


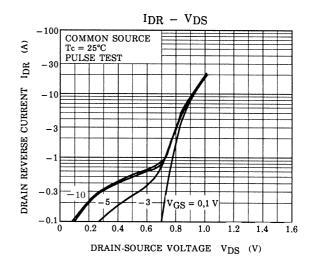


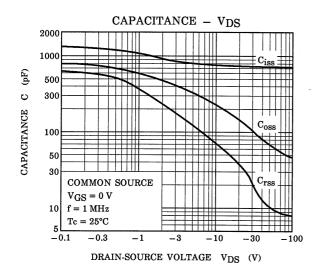


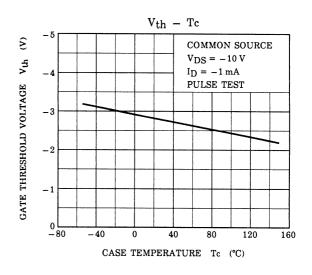


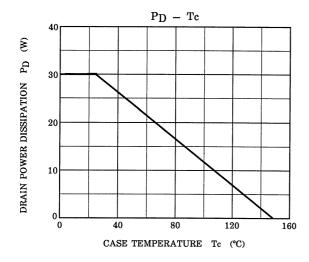
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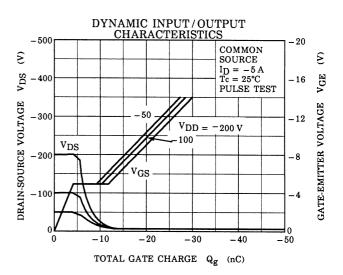




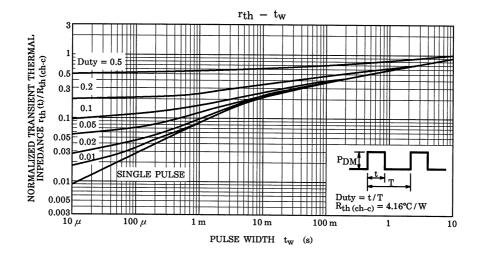


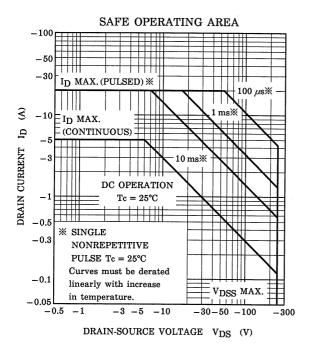


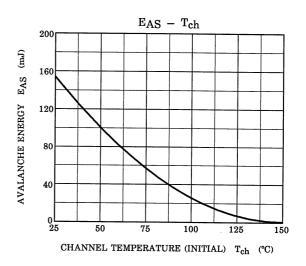


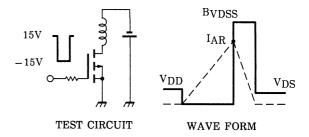


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$$\begin{array}{ll} R_G\!=\!25\Omega \\ V_{DD}\!=\!-50V,\; L\!=\!10.5mH \end{array} \quad E_{AS}\!=\!\frac{1}{2}\cdot L\cdot I^2\cdot (\frac{B_{VDSS}}{B_{VDSS}\!-\!V_{DD}})$$

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